

Search Notes

Application/Control No.

10/069,004

Examiner

Binh Q. Nguyen

Applicant(s)/Patent under
Reexamination

ARAMAKI, TAKASHI

Art Unit

2664

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------------|----------|
| 370 | 349 | 10/20/2005 | BQN |
| 370 | 470 | 10/20/2005 | |
| 370 | 471 | 10/20/2005 | |
| 370 | 466 | 10/20/2005 | |
| 370 | 467 | 10/20/2005 | |
| 370 | 468 | 10/20/2005 | |
| 370 | 350 | 10/20/2005 | |
| 370 | 329 | 10/20/2005 | |
| 709 | 249 | 10/20/2005 | |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|---|------------|------|
| EAST (US-GPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM-TDB), see more on search history. | 10/20/2005 | BQN |
| Consulted with Wellington Chin | 10/20/2005 | BQN |
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